

<b>Notice of References Cited</b>	Application/Control No. 10/722,495	Applicant(s)/Patent Under Reexamination LIN, YU-KAI	
	Examiner Natalie K. Walford	Art Unit 2879	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,161,910	12-2000	Reisenauer et al.	315/309
	B	US-			
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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